# **Z0109MA**

## Logic level four-quadrant triac

Rev. 03 — 4 August 2009

**Product data sheet** 

## 1. Product profile

## 1.1 General description

Passivated sensitive gate 4-Q triac in a SOT54 plastic package

#### 1.2 Features and benefits

- Direct interfacing to logic level ICs
- Direct interfacing to low power gate drive circuits
- High blocking voltage of 600V
- Sensitive gate in four quadrants

## 1.3 Applications

- General purpose low power motor control
- Home appliances

- Industrial process control
- Low power AC Fan controllers

#### 1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{DRM}$	repetitive peak off-state voltage		-	-	600	V
I <sub>T(RMS)</sub>	RMS on-state current	full sine wave; T <sub>lead</sub> ≤ 38 °C; see <u>Figure 4</u> and <u>1</u>	-	-	1	Α
Static ch	aracteristics					
I <sub>GT</sub>	gate trigger current	$V_D = 12 \text{ V}; T_j = 25 \text{ °C}; T2+ G-;$ see <u>Figure 6</u>	-	-	10	mA
		$V_D = 12 \text{ V}; T_j = 25 \text{ °C}; T2- G-$	-	-	10	mA
		$V_D = 12 \text{ V}; T_j = 25 \text{ °C}; T2+ G+$	-	-	10	mA
		$V_D = 12 \text{ V}; T_j = 25 \text{ °C}; T2- G+$	-	-	10	mΑ



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## 2. Pinning information

Table 2. Pinning information

	_			
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	T2	main terminal 2		N.1
2	G	gate		T2T1
3	T1			sym051
			SOT54 (TO-92)	

## 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
Z0109MA	TO-92	plastic single-ended leaded (through hole) package; 3 leads	SOT54

## 4. Limiting values

Table 4. Limiting values

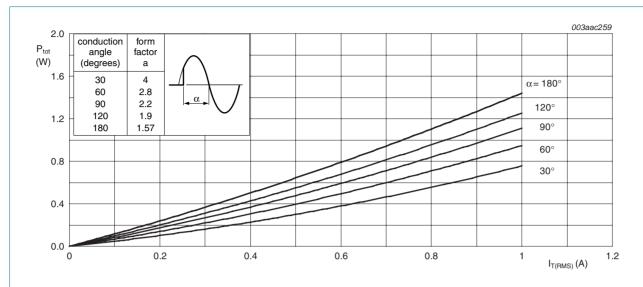
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DRM}$	repetitive peak off-state voltage		-	600	V
I <sub>T(RMS)</sub>	RMS on-state current	full sine wave; $T_{lead} \le 38$ °C; see Figure 4 and 1	-	1	Α
dI <sub>T</sub> /dt	rate of rise of on-state	$I_T = 1 \text{ A}$ ; $I_G = 20 \text{ mA}$ ; $dI_G/dt = 100 \text{ mA/}\mu\text{s}$ ; $T2 + G + G$	-	50	A/µs
	current	$I_T = 1 \text{ A}$ ; $I_G = 20 \text{ mA}$ ; $dI_G/dt = 100 \text{ mA/}\mu\text{s}$ ; $T2\text{- G+}$	-	20	A/µs
		$I_T = 1 \text{ A}$ ; $I_G = 20 \text{ mA}$ ; $dI_G/dt = 100 \text{ mA/}\mu\text{s}$ ; $T2 + G$	-	50	A/µs
		$I_T = 1 \text{ A}$ ; $I_G = 20 \text{ mA}$ ; $dI_G/dt = 100 \text{ mA/}\mu\text{s}$ ; T2- G-	-	50	A/µs
I <sub>GM</sub>	peak gate current		-	1	Α
$P_{GM}$	peak gate power		-	2	W
T <sub>stg</sub>	storage temperature		-40	150	°C
Tj	junction temperature		-	125	°C
I <sub>TSM</sub>	non-repetitive peak	full sine wave; $t_p = 16.7 \text{ ms}$ ; $T_{j(init)} = 25 \text{ °C}$	-	8.5	Α
	on-state current	full sine wave; $t_p$ = 20 ms; $T_{j(init)}$ = 25 °C; see Figure 2 and 3	-	8	Α
I <sup>2</sup> t	I <sup>2</sup> t for fusing	t <sub>p</sub> = 10 ms; sine-wave pulse	-	0.32	A <sup>2</sup> s
$P_{G(AV)}$	average gate power		-	0.1	W

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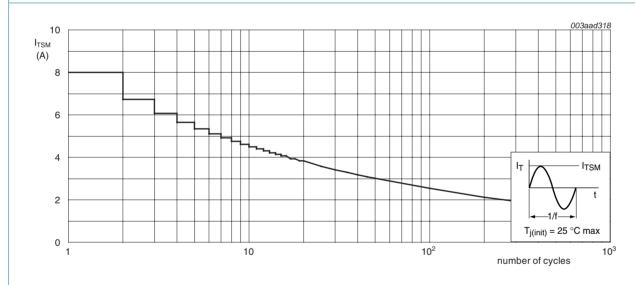
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 $\alpha$  = conduction angle

Total power dissipation as a function of RMS on-state current; maximum values

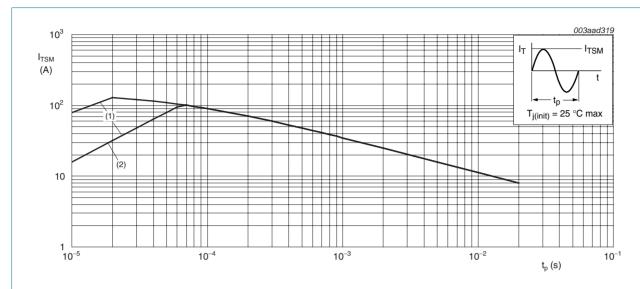


f = 50 Hz

Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum Fig 2. values

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 $t_p \le 20$  ms; (1) is  $dI_T/dt$  limit; (2) is T2 - G + quadrant limit

Fig 3. Non-repetitive peak on-state current as a function of pulse width; maximum values

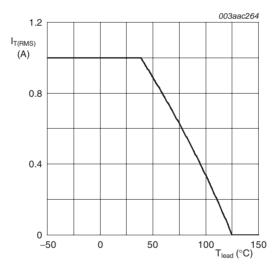


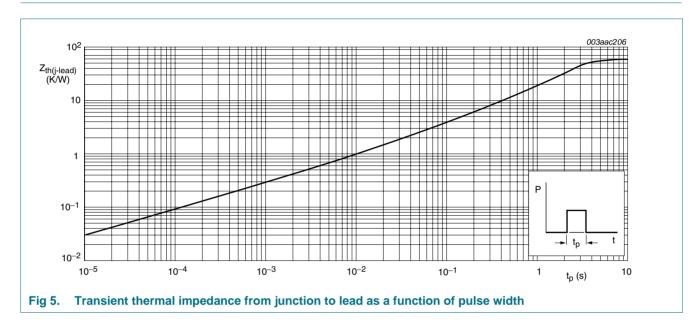
Fig 4. RMS on-state current as a function of lead temperature; maximum values

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## 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient		-	150	-	K/W
$R_{\text{th(j-lead)}}$	thermal resistance from junction to lead	Full cycle; see Figure 5	-	-	60	K/W



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## 6. Characteristics

Table 6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
$I_{GT}$	gate trigger current	$V_D = 12 \text{ V; } T_j = 25 \text{ °C; } T2 + G-; \text{ see } \frac{\text{Figure 6}}{\text{Model}}$	-	-	10	mA
		V <sub>D</sub> = 12 V; T <sub>j</sub> = 25 °C; T2- G-	-	-	10	mA
		V <sub>D</sub> = 12 V; T <sub>j</sub> = 25 °C; T2+ G+	-	-	10	mA
		V <sub>D</sub> = 12 V; T <sub>j</sub> = 25 °C; T2- G+	-	-	10	mA
I <sub>L</sub> latching current	$V_D = 12 \text{ V; } T_j = 25 \text{ °C; } I_G = 0.1 \text{ A; } T2 + G-;$ see Figure 7	-	-	25	mA	
		$V_D = 12 \text{ V}; T_j = 25 \text{ °C}; I_G = 0.1 \text{ A}; T2+ G+$	-	-	15	mA
		$V_D = 12 \text{ V}; T_j = 25 \text{ °C}; I_G = 0.1 \text{ A}; T2- G+$	-	-	15	mA
		$V_D = 12 \text{ V}; T_j = 25 \text{ °C}; I_G = 0.1 \text{ A}; T2- G-$	-	-	15	mA
I <sub>H</sub>	holding current	V <sub>D</sub> = 12 V; T <sub>j</sub> = 25 °C; see <u>Figure 10</u>	-	-	10	mA
$V_{T}$	on-state voltage	I <sub>T</sub> = 1 A; see <u>Figure 8</u>	-	1.3	1.6	V
$V_{GT}$	gate trigger voltage	$I_T = 0.1 \text{ A}$ ; $V_D = 12 \text{ V}$ ; $T_j = 25 \text{ °C}$ ; see <u>Figure 9</u>	-	-	1.3	V
		$I_T = 0.1 \text{ A}; V_D = 600 \text{ V}; T_j = 125 \text{ °C}$	0.2	-	-	V
I <sub>D</sub>	off-state current	V <sub>D</sub> = 600 V; T <sub>j</sub> = 125 °C	-	-	0.5	mA
Dynamic	characteristics					
dV <sub>D</sub> /dt	rate of rise of off-state voltage	$V_{DM}$ = 402 V; $T_j$ = 110 °C; gate open circuit; see <u>Figure 11</u>	50	-	-	V/µs
dV <sub>com</sub> /dt	rate of rise of commutating voltage	$V_D = 400 \text{ V}; T_j = 110 ^{\circ}\text{C}; dI_{com}/dt = 0.44 \text{ A/ms};$ gate open circuit	2	-	-	V/µs

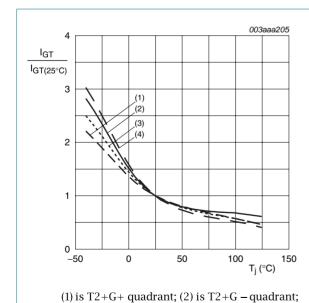


Fig 6. Normalized gate trigger current as a function of junction temperature

(3) is T2 - G – quadrant; (4) is T2 - G+ quadrant

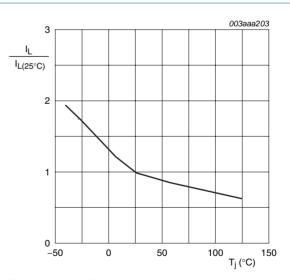
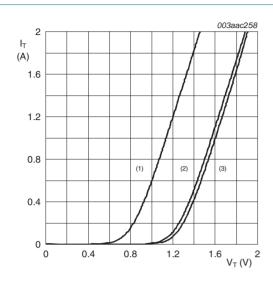


Fig 7. Normalized latching current as a function of junction temperature

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 $V_0=1.254~{
m V;}\,{
m R_s}=0.31\,\Omega$  (1)  $T_j=125~{
m ^{\circ}C;}$  typical values

(2)  $T_i = 125$  °C; maximum values

(3)  $T_i = 25$  °C; maximum values

Fig 8. On-state current as a function of on-state voltage

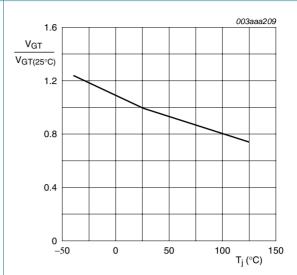


Fig 9. Normalized gate trigger voltage as a function of junction temperature

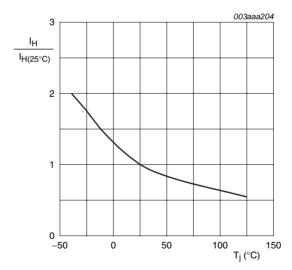


Fig 10. Normalized holding current as a function of junction temperature

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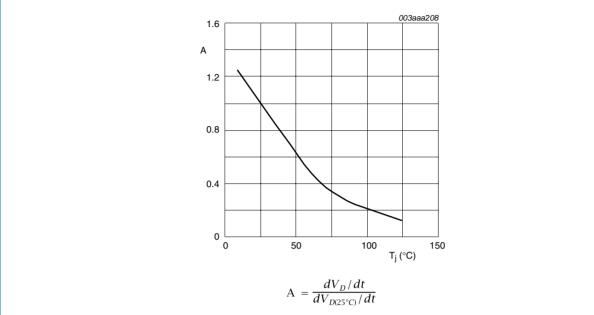
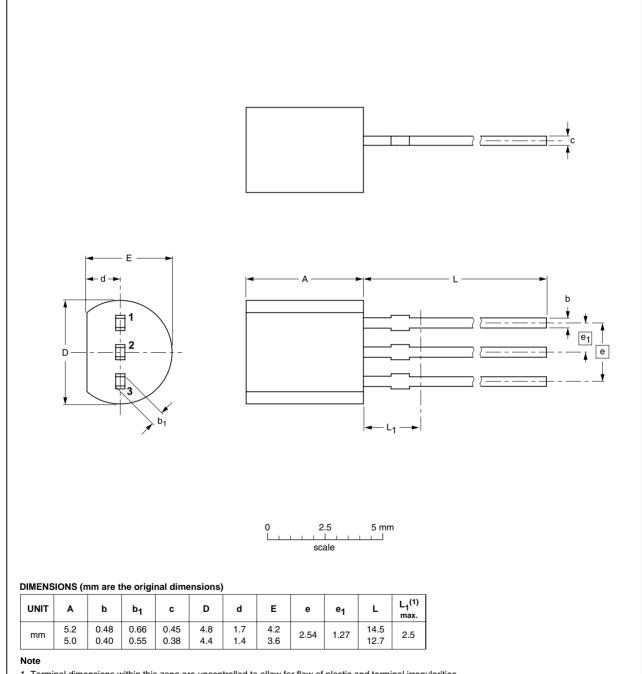


Fig 11. Normalized critical rate of rise of off-state voltage as a function of junction temperature;typical values

## 7. Package outline

#### Plastic single-ended leaded (through hole) package; 3 leads

SOT54



1. Terminal dimensions within this zone are uncontrolled to allow for flow of plastic and terminal irregularities.

OUTLINE			REFER	ENCES	EUROPEAN	ISSUE DATE
	VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
	SOT54		TO-92	SC-43A		<del>-04-06-28-</del> 04-11-16

Fig 12. Package outline SOT54 (TO-92)

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## Logic level four-quadrant triac

## 8. Revision history

### Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
Z0109MA_3	20090804	Product data sheet	-	Z0103_07_09_SERIES-02
Modifications:	guidelines • Legal texts	of this data sheet has been of NXP Semiconductors. have been adapted to the per Z0109MA separated from	e new company nan	• • •
Z0103_07_09_SERIES-02 (9397 750 10102)	20020912	Product data	-	Z0103_07_09_SERIES-01
Z0103_07_09_SERIES-01 (9397 750 09419)	20020411	Product data	-	-

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#### 9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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